**TITLE**

AUTHOR[[1]](#footnote-1)–AUTHOR[[2]](#footnote-2)

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**Keywords**: keyword1, keyword2, keyword3, keyword4, keyword5

# Introduction

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# 1. Materials and methods

## 1.1 Measuring device

## 1.2 ……

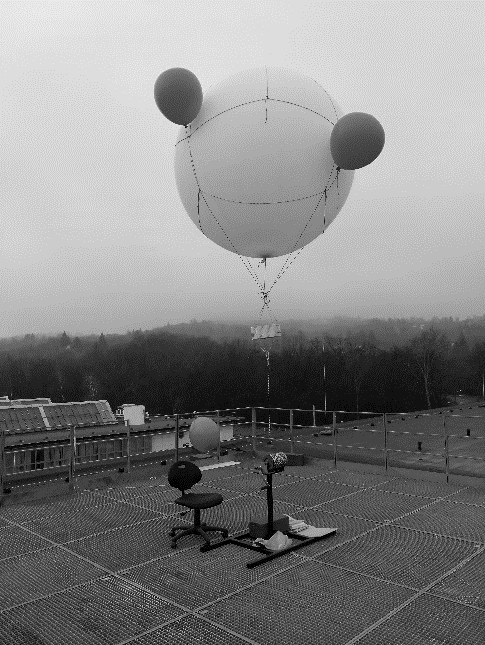
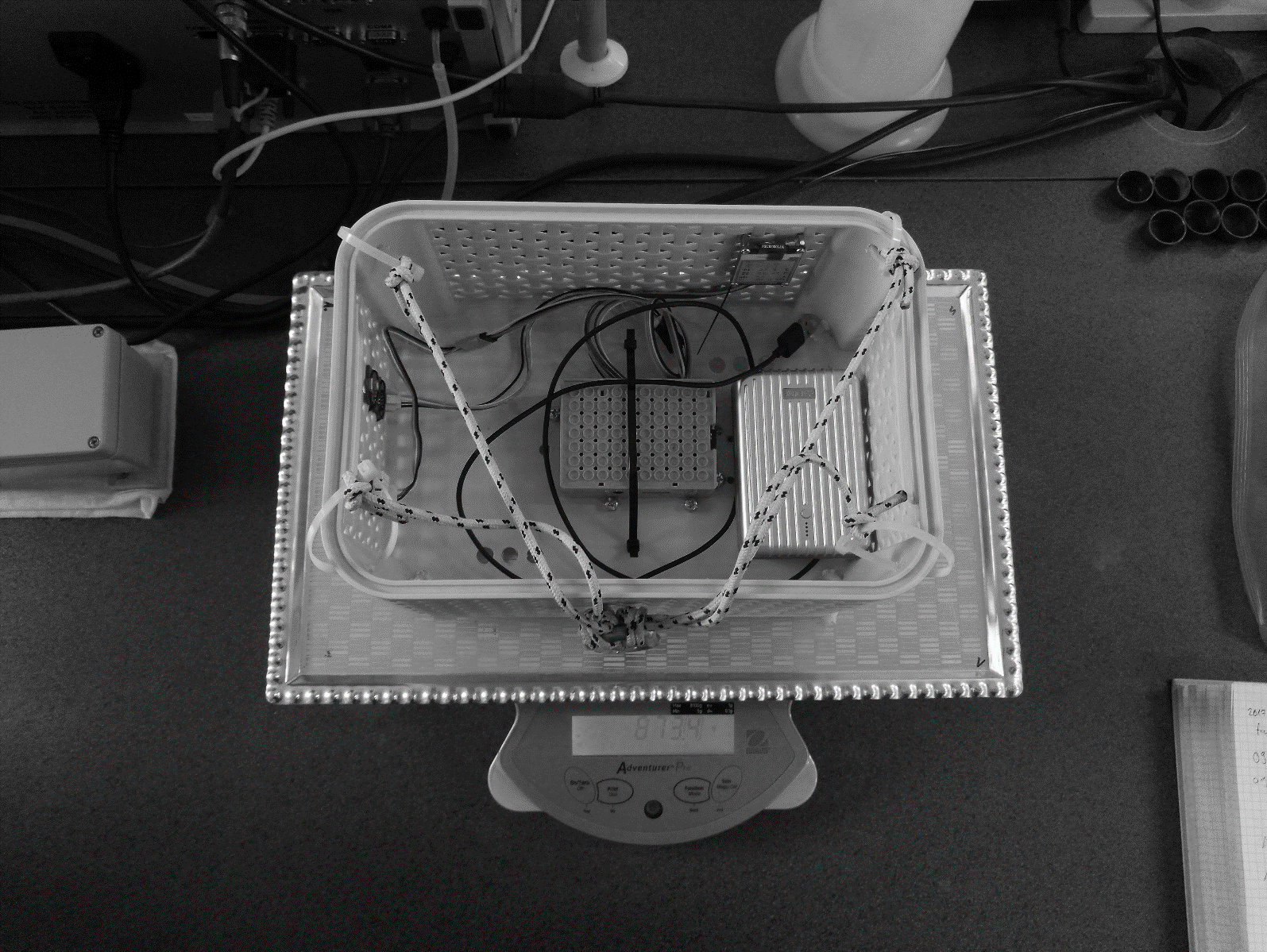


Figure 1. Test box and the compiled measuring system

Table 1.Effect of meteorological variables to PM10 concentration [1]

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# Conclusion

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# Acknowledgements

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